

Inelastic Electron Tunneling via Molecular Vibrations in Single-Molecule Transistors

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In single-molecule transistors, we observe inelastic cotunneling features that correspond energetically to vibrational excitations of the molecule, as determined by Raman and infrared spectroscopy. This is a form of inelastic electron tunneling spectroscopy of single molecules, with the transistor geometry allowing *in situ* tuning of the electronic states via a gate electrode. The vibrational features shift and change shape as the electronic levels are tuned near resonance, indicating significant modification of the vibrational states. When the molecule contains an unpaired electron, we also observe vibrational satellite features around the Kondo resonance.

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Electron tunneling is widespread throughout chemistry and condensed matter physics. Electron transfer through molecules by nonresonant tunneling has long been known [1,2], and tunneling electrons can interact inelastically with molecules, exciting vibrational modes. This is the basis of inelastic electron tunneling spectroscopy (IETS) [3,4], recently refined to probe groups of molecules via crossed wires [5–7] and nanopores [8], and single molecules via scanning tunneling microscopy (STM) [9]. Similar inelastic, nonresonant tunneling occurs in single-electron transistors (SETs) [10,11], three-terminal devices in which a gate electrode allows *in situ* adjustment of the energy levels. To date, this tuning has not been possible in the chemical systems examined by IETS.

In this Letter we report inelastic cotunneling processes in single-molecule transistors (SMTs) [12–15], and identify them with vibrational excitations of the molecules, as determined by Raman and infrared spectroscopy. Tuning electronic levels near resonance reveals shifts in inelastic line shapes and peak positions, suggesting significantly modified electron-vibrational coupling in this region. The vibrational features persist in the Kondo regime, indicating a complicated conduction process involving vibrational excitations of a many-body electronic system.

A confined electronic system (“island”) coupled by tunneling to source and drain electrodes is shown schematically in Fig. 1(a). The energy to promote an electron from the highest occupied to the lowest unoccupied orbital is the single-particle level spacing, Δ . Ignoring spin, adding an electron to the island also requires additional Coulomb “charging energy,” E_c , often approximated by the charging energy of a classical capacitor. In molecules, vibrational excitations are associated with each electronic state. In a three-terminal device, the island levels may be shifted via a gate potential. Figure 1(b) maps the differential conductance, $\partial I_D / \partial V_{SD}$, of a generic SET as a function of source-drain bias, V_{SD} , and gate voltage, V_G , while

Fig. 1(c) shows possible electronic transport mechanisms. For low biases [Fig. 1(c), 1,1’] the average number of electrons on the island is fixed; transport is suppressed (Coulomb blockade) and can only occur by higher order tunneling through virtual states. An example of this in chemical electron transfer is “superexchange” [2], and in SETs such processes are called “elastic cotunneling” [10]. At higher biases in the blocked regime, “inelastic cotunneling” via an excited virtual state [Fig. 1(c), 2] is possible. For an excitation of energy E^* , the opening of

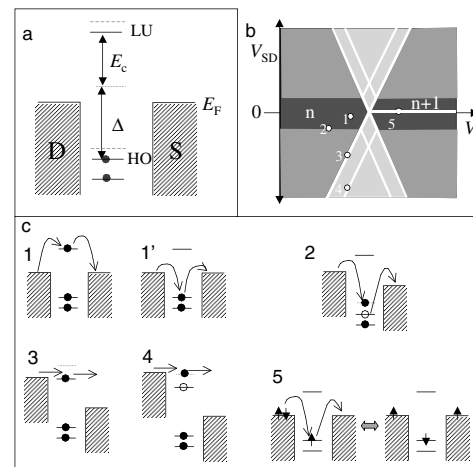


FIG. 1. (a) Energetics of single-electron transistor, with Δ = single-particle level spacing, E_c = charging energy. Dashed levels indicate manifold of vibrational excitations in molecular devices. (b) Map of $\partial I_D / \partial V_{SD}$ (brightness) of such an SET, vs source-drain bias V_{SD} and gate voltage V_G , showing one Coulomb transition from n to $n+1$ electrons on the island. Numbered points refer to the transport regimes shown in (c). (c) Relevant conduction processes in (b): 1 = elastic cotunneling; 2 = inelastic cotunneling; 3 = resonant conduction; 4 = resonant inelastic conduction; 5 = Kondo resonant conduction.

the inelastic channel results in a feature in $\partial^2 I_D / \partial V_{SD}^2$ at $eV_{SD} = E^*$. Inelastic cotunneling via electronically excited states has been seen in semiconductor [11] and carbon nanotube SETs [16]. Inelastic cotunneling via vibrationally excited molecules is responsible for conventional IETS [17], but has not been studied in three-terminal devices. IETS line shapes are predicted to vary depending on the virtual state energies [18], and can be peaks, dips, or intermediate structures in $\partial^2 I_D / \partial V_{SD}^2$. At higher source-drain biases [Fig. 1(c), 3] Coulomb blockade is lifted leading to significant resonant conduction, while at still higher biases [Fig. 1(c), 4] additional resonant conduction occurs when eV_{SD} is sufficient to leave the island in an electronically [19–21] or vibrationally [12,13,15,22] excited state.

When the effects of unpaired spins are included, the Kondo resonance becomes a possible conduction mechanism, and is detected as a sharp conductance peak near zero bias [23,24] at temperatures low compared to a characteristic energy scale, $k_B T_K$. The maximum peak conductance possible is $2e^2/h$, for a system with perfectly symmetric coupling between the island and the source and drain electrodes. Kondo physics has been observed recently in single-molecule transistors [13–15].

Single-molecule transistors open the possibility of examining inelastic cotunneling in individual, tunable chemical systems, in both the blocked and Kondo regimes. We fabricate SMTs [Fig. 2(a)] using an electromigration method that has been described extensively [12–15]. The source and drain electrodes are 15 nm Au films with one nm Ti adhesion layers, prepared by electron beam lithography, *e*-beam evaporation, liftoff, and oxygen plasma cleaning. The gate oxide is 200 nm SiO₂, with a degener-

ately doped *p*+ Si (100) wafer as the underlying gate electrode. We routinely obtain excellent device reliability up to gate fields of 5×10^8 V/m with negligible leakage.

The starting molecule, **1**, [Fig. 2(b)] comprises a single transition metal ion (Co²⁺) coordinated by conjugated ligands; the valence state of the ion may be controlled electrochemically [Fig. 2(c)]. The structure of **1** has been verified by x-ray crystallography. Compound **1** undergoes loss of the (CN) moieties upon assembly on gold in tetrahydrofuran (THF), yielding the corresponding di- or tri-thiolate, which is bound covalently to surface Au atoms [25]. Both **1** and its self-assembly have been characterized extensively by x-ray photoemission, ellipsometry, and electrochemical methods [26].

A 2 mM solution of **1** in THF is allowed to self-assemble on the electrode sets for 48 h. The chip is then rinsed in THF, dried in a nitrogen stream, and placed in a variable temperature vacuum probe station (Desert Cryogenics). Electromigration into separate source and drain electrodes proceeds as described previously [15].

At a variety of temperatures, we have measured I_D as a function of V_{SD} at V_G from -100 to $+100$ V using a semiconductor parameter analyzer (HP4145B), with the source grounded and the drain electrode swept. We compute $\partial I_D / \partial V_{SD}$ and $\partial^2 I_D / \partial V_{SD}^2$ as a function of V_{SD} and V_G by numerical differentiation. Comparisons between this approach and lock-in techniques show excellent agreement [26]. We identify features in $\partial^2 I_D / \partial V_{SD}^2$ by comparing multiple data sets taken at the same or nearby gate voltages.

We have examined 407 electrode pairs on 10 separate substrates, with statistics similar to those in previous investigations [15]. Of the electrode pairs examined we found 57 devices with no detectable current (electrodes too far apart for measurable conduction); 166 with linear, nongateable current-voltage characteristics (likely no molecule present at the junction); 108 with nonlinear but ungatetable current-voltage characteristics (either molecules or metal nanoparticles with negligible gate coupling); and 76 nonlinear but significantly gateable current-voltage characteristics. From this last group, four were identified as single-electron devices based on unintentionally produced metal nanoparticles [15]. In working devices, bias sweeps were restricted to $|V_{SD}| < 200$ mV to minimize the chances of current-induced irreversible changes. Device stability is poor at high current densities and temperatures significantly above 4.2 K, likely due to the atomic diffusion of the Au electrode material.

There are 27 devices that cleanly display a single Coulomb degeneracy point, the vast majority of which show a resonance at zero V_{SD} in one charge state identified as a Kondo resonance, as in Fig. 2(d). The electron addition energy typically exceeds 100 meV [see Fig. 2(d)]. Control devices with electrodes exposed to THF without **1** never display such properties. Kondo features are similar to those

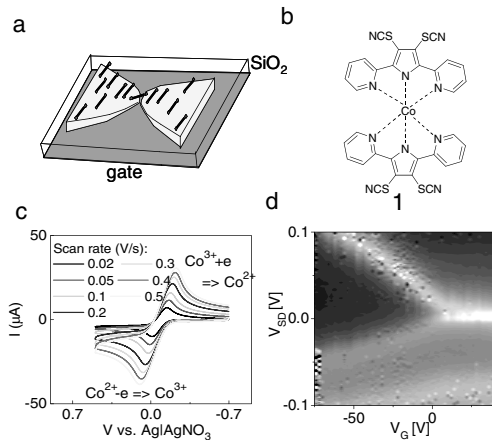


FIG. 2. (a) Diagram of typical single-molecule transistor fabricated by electromigration. (b) structure of **1**, the compound of interest. (c) Cyclic voltammograms showing reversible change in Co ion charge state [26]. (d) Differential conductance of a transistor containing **1**, at 5 K. White corresponds to $\partial I_D / \partial V_{SD} = 3 \times 10^{-6} S$. The zero-bias peak in the right-hand charge state is characteristic of Kondo resonant conduction.

reported in earlier Co^{2+} -containing complexes [13]. Typical Kondo temperatures as inferred from the temperature dependence of the Kondo resonance height and the low temperature width of the resonance are ~ 40 K. The low temperature limit of the resonance peak height is often reduced from the theoretical maximum value of $2e^2/h$, indicating asymmetric coupling of the molecule to the source and drain electrodes.

In 12 devices, the conductance in the classically blockaded region and/or outside the Kondo resonance is large enough to allow clean measurements of $\partial^2 I_D / \partial V_{SD}^2$. In Fig. 3, we show maps of this quantity as a function of V_{SD} and V_G in two different devices at 5 K. We have indicated two prominent features within the blockaded (Kondo) regime with black arrows. Features in $\partial^2 I_D / \partial V_{SD}^2$ of opposite sign are symmetrically located around zero source-drain bias, consistent with inelastic tunneling expectations. Some asymmetry in shape is unsurprising, given that the low peak conductance in the Kondo regime for these devices indicates asymmetric coupling of the molecule to the leads.

The $\partial^2 I_D / \partial V_{SD}^2$ features in the blockaded region occur at essentially constant values of V_{SD} until V_G is varied such that the feature approaches the edge of the blockaded region. This constancy in V_G has been identified as a feature of inelastic cotunneling in semiconductor [11] and nanotube [16] single-electron devices. The changes in these features as the boundaries of the Coulomb stability region are crossed indicate that the inelastic processes are native to the SMT itself, and not due to some parallel conduction channel. The inelastic modes occur at energies low compared to Δ (~ 100 s of meV), implying that the modes being excited are unlikely to be electronic. We examined the $\partial^2 I_D / \partial V_{SD}^2$ vs V_{SD} data for features that remain at fixed V_{SD} as V_G is varied. We identified a total of 43 candidate inelastic features at $V_{SD} < 120$ meV, rang-

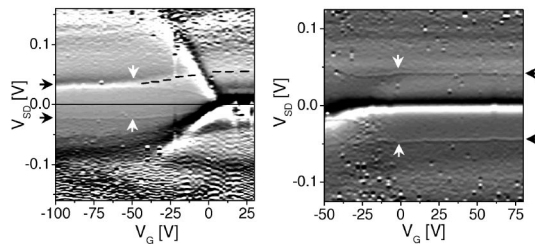


FIG. 3. Maps of $\partial^2 I_D / \partial V_{SD}^2$ as a function of V_{SD} and V_G at 5 K for two devices. Smoothing window in V_{SD} is 5 mV. Brightness scales are -8×10^{-5} A/V² (black) to 3×10^{-5} A/V² (white), and -2×10^{-5} A/V² (black) to 2×10^{-5} A/V², respectively. The zero-bias features correspond to Kondo peaks in $\partial I_D / \partial V_{SD}$. Prominent inelastic features are indicated by black arrows. In both devices, when the inelastic features approach the boundaries of the Coulomb blockade region, these levels shift and alter line shape (white arrows). Black dashed line in left map traces an inelastic feature across the Coulomb blockade region boundary and into the Kondo regime.

ing in apparent width from 5 to 20 mV at ~ 5 K. The narrowest inelastic features clearly show a broadening as the temperature is elevated above 20 K.

Figure 4 shows a histogram (bin = 1 mV) of the V_{SD} positions of those features, from detailed examination of $\partial^2 I_D / \partial V_{SD}^2$ vs V_{SD} data. The lower panel shows Raman (Stokes) peak positions (data taken on a powder of **1**) and IR absorption peak positions of **1** (in pellet form, blended with KBr) [26]. The correlations between the spectra and inelastic features in $\partial^2 I_D / \partial V_{SD}^2$ confirm that vibrational inelastic cotunneling processes are at work in the molecular transistors. This is consistent with the observation of IETS in single molecules by STM [9]. The fact that different SMTs exhibit different subsets of features is a natural consequence of the sensitivity of IETS to the nanoscale structure of the molecular junction [27]. Comparisons with Raman of **1** and related compounds (e.g., ligands without -SCN; ligands without Co^{2+}) suggest tentative peak assignments. The peaks near 36 and 55 meV are likely the Co-N stretch [28], while that near 44 meV is tentatively a -SCN deformation [28] (implying that not every S is bonded to an Au surface atom, consistent with x-ray photoemission data [26]). The 24 meV peak is tentatively the Au-S bond [29]; this claim is further supported by the appearance of a ~ 28 meV Raman peak in films of **1** assembled on Au electrodes, while such a peak is absent in Raman spectra of both unassembled **1** and bare electrodes.

As indicated by white arrows in Fig. 3, inelastic features change near the boundary of the Coulomb blockade region. These changes as a function of V_G are qualitatively consistent with recent theoretical expectations [18]. The energy of the virtual cotunneling states is shifted by V_G , altering the (complex) amplitude for that process. Changing the cotunneling amplitude compared to quasi-

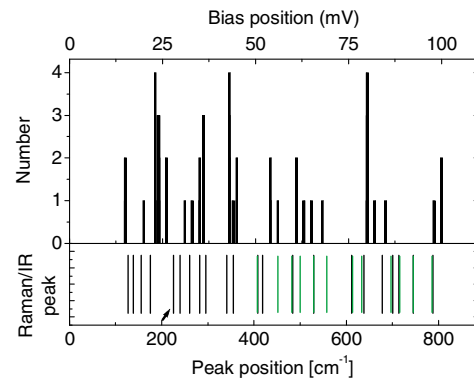


FIG. 4 (color online). (top) Histogram of $|V_{SD}|$ positions of 43 features in $\partial^2 I_D / \partial V_{SD}^2$ that are persistent at constant V_{SD} over at least a 10 V gate voltage range, for the 12 samples discussed. Bin size is 1 meV. Width of actual features is at least 5 meV, with position indicating feature center. (bottom) Raman (black) and IR (gray) peak positions taken of **1** in the solid state at room temperature. The indicated Raman peak near 28 meV is only present in films of **1** self-assembled on Au electrodes.

elastic (with the virtual excitation and readsorption of a vibrational quantum) or direct source-drain tunneling is predicted to severely alter line shapes. Occasionally inelastic features shift significantly in energy as the blockade boundary is approached [e.g., the 24 meV features in Fig. 3 (left)]. This would be consistent with a modified (dressed) electron-vibrational coupling near the electronic resonance.

We observe that the IETS features persist into the Kondo regime in the form of satellite features paralleling the zero-bias Kondo resonance. Often specific features may be traced from the blocked region into the Kondo region, an example of which is indicated by the dashed line in Fig. 3 (left). Through the transition the inelastic feature line shapes change, as do their intensities. Such inelastic satellites paralleling the Kondo resonance have been suggested previously [14,15], and the consistency in feature position in our data lend strong support to this idea. Recent experiments [30] have demonstrated satellite Kondo peaks when a semiconductor Kondo system interacts inelastically with photons of a well defined energy. In the analogous SMT case, inelastic exchange occurs with vibrational quanta of the molecule. These Kondo measurements illustrate how the tunability of single-molecule transistors permits the examination of vibrational processes as a function of the energetics of the electronic levels, a study not possible in standard two-terminal devices.

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